



# CPC1001N Optocoupler: Unidirectional Input, Single-Transistor Output

Parameter	Rating	Units
Breakdown Voltage BV <sub>CEO</sub>	30	V
Current Transfer Ratio (Min)	100	%
Saturation Voltage	0.3	V
Input Control Current	0.2	mA

# **Features**

- · 100mA Continuous Load Rating
- 1500V<sub>rms</sub> Input/Output Isolation
- Small 4-Pin SOP Package
- Tape & Reel Version Available

# **Applications**

- Loop Detect
- Ringing Detect
- Sensor Circuitry
- Instrumentation
- Multiplexers
- Data Acquisition
- I/O Subsystems
- Industrial Control

# **Description**

CPC1001N is a unidirectional input optocoupler with a single transistor output. Current transfer ratios range from 100% to 800%.

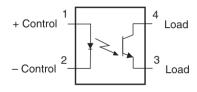
# **Approvals**

- UL Recognized Component: File E76270
- CSA Certified Component: Certificate 1172007
- TUV EN 62368-1: Certificate # B 082667 0008

# **Ordering Information**

Part #	Description
CPC1001N	4-Pin SOP (100/Tube)
CPC1001NTR	4-Pin SOP Surface Mount (2000/Reel)

# **Pin Configuration**











# Absolute Maximum Ratings @ 25°C

Parameter	Ratings	Units
Input Power Dissipation <sup>1</sup>	150	mW
Input Control Current	5	mA
Peak (10ms)	1	Α
Reverse Input Voltage	5	V
Phototransistor <sup>2</sup>	150	mW
Isolation Voltage, Input to Output	1500	V <sub>rms</sub>
Operational Temperature, Ambient	-40 to +85	°C
Storage Temperature	-40 to +125	°C

<sup>1</sup> Derate linearly 1.33 mW / °C

2

Absolute Maximum Ratings are stress ratings. Stresses in excess of these ratings can cause permanent damage to the device. Functional operation of the device at conditions beyond those indicated in the operational sections of this data sheet is not implied.

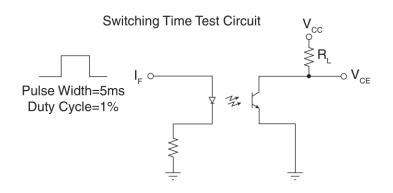
Typical values are characteristic of the device at +25°C, and are the result of engineering evaluations. They are provided for information purposes only, and are not part of the manufacturing testing requirements.

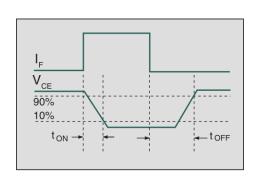
# **Electrical Characteristics @ 25°C**

Parameters	Conditions	Symbol	Min	Тур	Max	Units
Output Characteristics						
Phototransistor Blocking Voltage	I <sub>CEO</sub> =10μA	BV <sub>CEO</sub>	30	90	-	V <sub>P</sub>
Phototransistor Output (Dark) Current	I <sub>F</sub> =0mA, V <sub>CEO</sub> =5V	I <sub>CEO</sub>	-	9	500	nA
Saturation Voltage	I <sub>F</sub> =1mA, I <sub>C</sub> =1mA	V <sub>CE(sat)</sub>	-	-	0.3	V
Current Transfer Ratio	I <sub>F</sub> =0.2mA, V <sub>CE</sub> =0.5V	CTR	100	330	800	%
Output Capacitance	V <sub>CEO</sub> =25V, f=1MHz	C <sub>OUT</sub>	-	6	-	pF
Input Characteristics						
Input Control Current	I <sub>C</sub> =0.2mA, V <sub>CE</sub> =0.5V	I <sub>F</sub>	-	0.1	0.2	mA
Input Voltage Drop	I <sub>F</sub> =5mA	V <sub>F</sub>	0.9	1.2	1.5	V
Input Reverse Current	V <sub>R</sub> =5V	I <sub>R</sub>	-	-	10	μΑ
Common Characteristics	Common Characteristics					
Input to Output Capacitance	-	C <sub>I/O</sub>	-	3	-	pF

# Switching Characteristics @ 25°C

Characteristic	Symbol	Test Condition	Тур	Units	
Turn-On Time	t <sub>on</sub>	$I_{\rm E}$ =2mA, $V_{\rm CC}$ =5V, $R_{\rm I}$ =1K $\Omega$	1	116	
Turn-Off Time	t <sub>off</sub>	1 <sub>F</sub> -2111A, V <sub>CC</sub> -5V, 11 <sub>L</sub> -11\(\sigma \)2	30	μS	

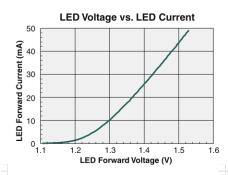


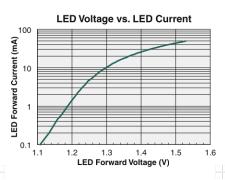


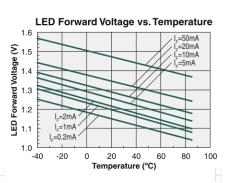
<sup>&</sup>lt;sup>2</sup> Derate linearly 2.00 mW / °C

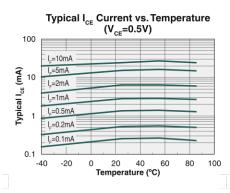


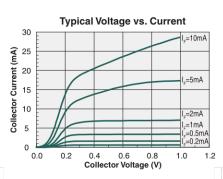
#### **PERFORMANCE DATA\***

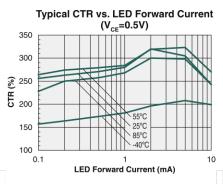


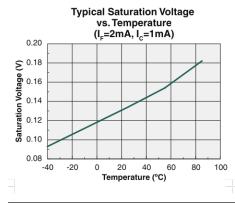


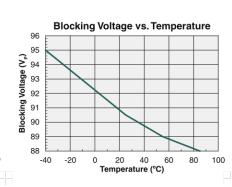


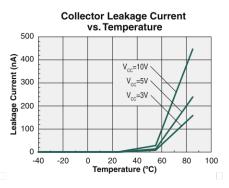


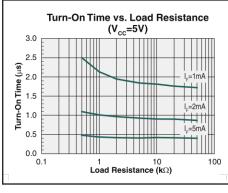


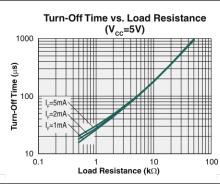












Refer to the Test Circuit on the previous page for these two graphs.

\*Unless otherwise noted, data presented in these graphs is typical of device operation at 25°C.



# **Manufacturing Information**

#### **Moisture Sensitivity**

All plastic encapsulated semiconductor packages are susceptible to moisture ingression. IXYS Integrated Circuits classifies its plastic encapsulated devices for moisture sensitivity according to the latest version of the joint industry standard, IPC/JEDEC J-STD-020, in force at the time of product evaluation. We test all of our products to the maximum conditions set forth in the standard, and guarantee proper operation of our devices when handled according to the limitations and information in that standard as well as to any limitations set forth in the information or standards referenced below.

Failure to adhere to the warnings or limitations as established by the listed specifications could result in reduced product performance, reduction of operable life, and/or reduction of overall reliability.

This product carries a **Moisture Sensitivity Level (MSL)** classification as shown below, and should be handled according to the requirements of the latest version of the joint industry standard **IPC/JEDEC J-STD-033**.

Device	Moisture Sensitivity Level (MSL) Classification
CPC1001N	MSL 3

#### **ESD Sensitivity**



This product is ESD Sensitive, and should be handled according to the industry standard JESD-625.

## **Soldering Profile**

Provided in the table below is the **IPC/JEDEC J-STD-020** Classification Temperature  $(T_C)$  and the maximum total dwell time  $(t_p)$  in all reflow processes that the body temperature of these surface mount devices may be  $(T_C - 5)^{\circ}C$  or greater. The device's body temperature must not exceed the Classification Temperature at any time during reflow soldering processes.

Device	Classification Temperature (T <sub>c</sub> )	Dwell Time (t <sub>P</sub> )	Max Reflow Cycles
CPC1001N	260°C	30 seconds	3

#### **Board Wash**

IXYS Integrated Circuits recommends the use of no-clean flux formulations. Board washing to reduce or remove flux residue following the solder reflow process is acceptable provided proper precautions are taken to prevent damage to the device. These precautions include but are not limited to: using a low pressure wash and providing a follow up bake cycle sufficient to remove any moisture trapped within the device due to the washing process. Due to the variability of the wash parameters used to clean the board, determination of the bake temperature and duration necessary to remove the moisture trapped within the package is the responsibility of the user (assembler). Cleaning or drying methods that employ ultrasonic energy may damage the device and should not be used. Additionally, the device must not be exposed to halide flux or solvents.



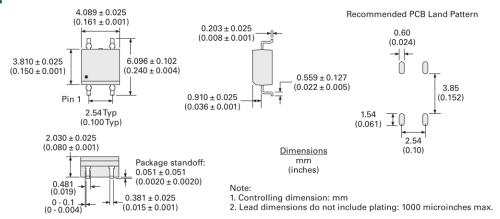




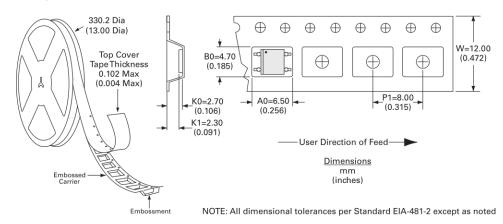


#### **MECHANICAL DIMENSIONS**

# **CPC1001N**



# **CPC1001NTR Tape & Reel**



For additional information please visit our website at: https://www.ixysic.com



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